FUJITSU SEMICONDUCTOR
DATA SHEET

DS04-21357-2E

*ASSP*

# Dual Serial Input PLL Frequency Synthesizer

# MB15F03SL

## ■ DESCRIPTION

The Fujitsu MB15F03SL is a serial input Phase Locked Loop (PLL) frequency synthesizer with a 1750 MHz and a 600 MHz prescalers. The 1750 MHz prescaler, and 600 MHz prescaler have a dual modulus division ratio of 64/65 or 128/129 and 8/9 or 16/17 enabling pulse swallow operation.

The supply voltage range is between 2.4 V and 3.6 V.

The MB15F03SL uses the latest BiCMOS process. As a result, the supply current is typically 3.5 mA at 2.7 V. A refined charge pump supplies a well-balanced output current of 1.5 mA or 6 mA. The charge pump current is selectable by serial data.

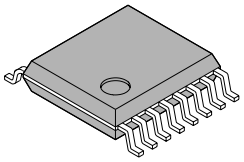
MB15F03SL is ideally suited for wireless mobile communications, such as GSM and PDC.

## ■ FEATURES

- High frequency operation: RF synthesizer: 1750 MHz max
  IF synthesizer: 600 MHz max
- Low power supply voltage: $V_{CC}$ = 2.4 to 3.6 V
- Ultra Low power supply current: $I_{CC}$ = 3.5 mA typ. ($V_{CC}$ = 2.7 V, Ta = +25°C, in IF, RF locking state)
  $I_{CC}$ = 4.0 mA typ. ($V_{CC}$ = 3.0 V, Ta = +25°C, in IF, RF locking state)
- Direct power saving function: Power supply current in power saving mode
  Typ. 0.1 µA ($V_{CC}$ = 3V, Ta = +25°C), Max. 10 µA ($V_{CC}$ = 3V)
- Dual modulus prescaler: 1750 MHz prescaler (64/65 or 128/129)/600 MHz prescaler (8/9 or 16/17)
- Serial input 14-bit programmable reference divider: R = 3 to 16,383
- Serial input programmable divider consisting of:
  - Binary 7-bit swallow counter: 0 to 127
  - Binary 11-bit programmable counter: 3 to 2,047
- Software selectable charge pump current
- On–chip phase control for phase comparator
- Operating temperature: Ta = –40 to +85°C
- Pin compatible with MB15F03, MB15F03L

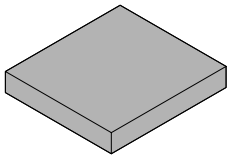
## ■ PACKAGES

16-pin plastic SSOP



(FPT-16P-M05)

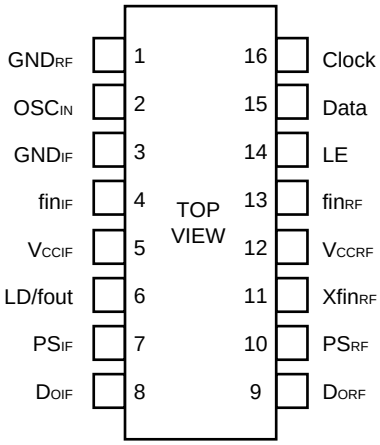
16-pad plastic BCC



(LCC-16P-M04)

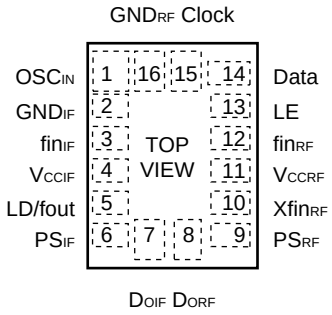
## ■ PIN ASSIGNMENTS

16-pin SSOP




(FPT-16P-M05)

16-pad BCC

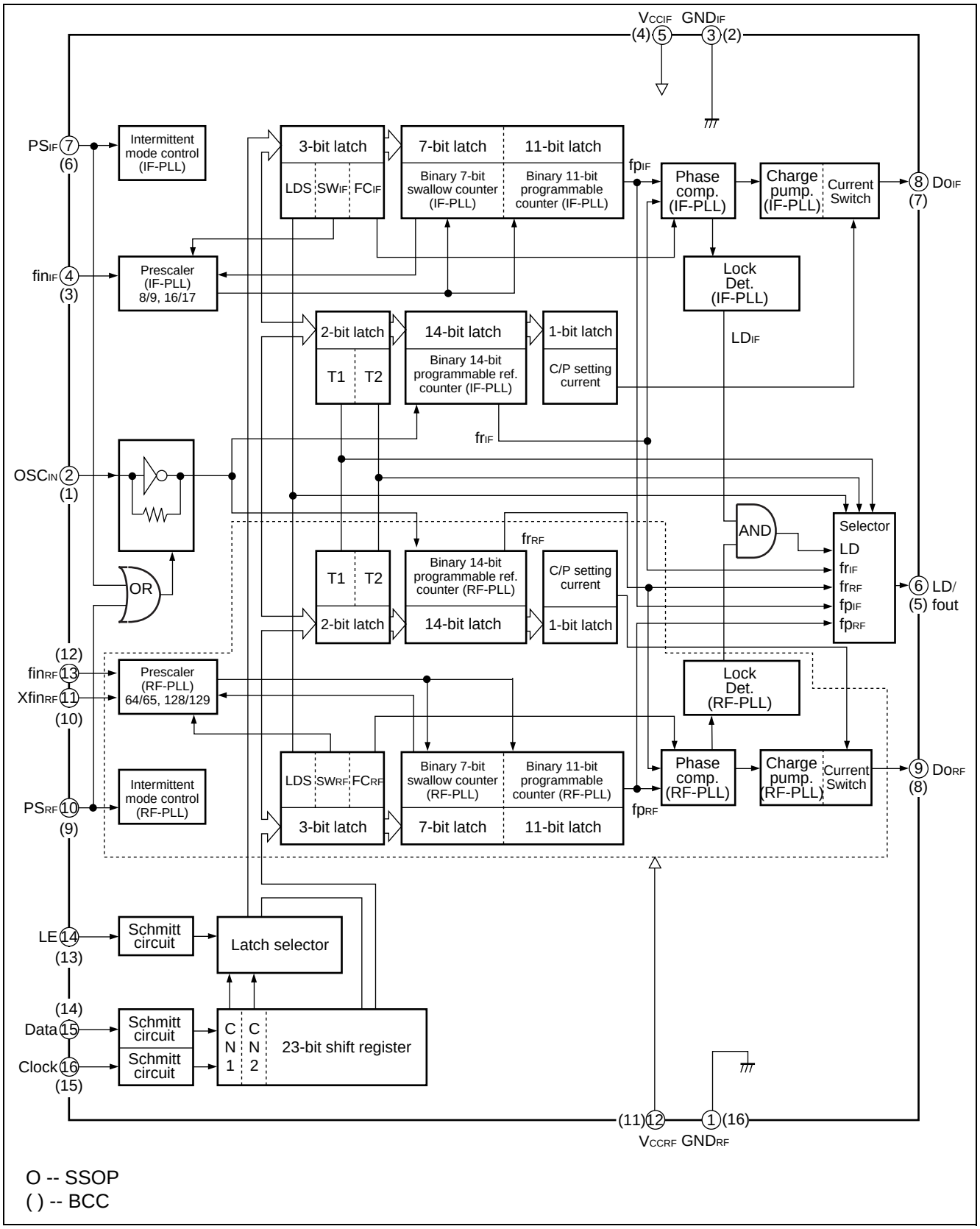



(LCC-16P-M04)

## ■ PIN DESCRIPTION

| Pin no. | | Pin name | I/O | Descriptions |
|---|---|---|---|---|
| SSOP | BCC | | | |
| 1 | 16 | $GND_{RF}$ | – | Ground for RF-PLL section. |
| 2 | 1 | $OSC_{IN}$ | I | The programmable reference divider input. TCXO should be connected with a AC coupling capacitor. |
| 3 | 2 | $GND_{IF}$ | – | Ground for the IF-PLL section. |
| 4 | 3 | $fin_{IF}$ | I | Prescaler input pin for the IF-PLL.<br>Connection to an external VCO should be via AC coupling. |
| 5 | 4 | $V_{CCIF}$ | – | Power supply voltage input pin for the IF-PLL section. |
| 6 | 5 | LD/fout | O | Lock detect signal output (LD)/phase comparator monitoring output (fout).<br>The output signal is selected by LDS bit in the serial data.<br>LDS bit = “H” ; outputs fout signal<br>LDS bit = “L” ; outputs LD signal |
| 7 | 6 | $PS_{IF}$ | I | Power saving mode control for the IF-PLL section. This pin must be set at “L” during Power-ON. (Open is prohibited.)<br>$PS_{IF}$ = “H” ; Normal mode<br>$PS_{IF}$ = “L” ; Power saving mode |
| 8 | 7 | $Do_{IF}$ | O | Charge pump output for the IF-PLL section.<br>Phase characteristics of the phase detector can be selected via programming of the FC-bit. |
| 9 | 8 | $Do_{RF}$ | O | Charge pump output for the RF-PLL section.<br>Phase characteristics of the phase detector can be selected via programming of the FC-bit. |
| 10 | 9 | $PS_{RF}$ | I | Power saving mode control for the RF-PLL section. This pin must be set at “L” during Power-ON. (Open is prohibited.)<br>$PS_{RF}$ = “H” ; Normal mode<br>$PS_{RF}$ = “L” ; Power saving mode |
| 11 | 10 | $Xfin_{RF}$ | I | Prescaler complementary input for the RE-PLL section.<br>This pin should be grounded via a capacitor. |
| 12 | 11 | $V_{CCRF}$ | – | Power supply voltage input pin for the RF-PLL section, the shift register and the oscillator input buffer. When power is OFF, latched data of RF-PLL is lost. |
| 13 | 12 | $fin_{RF}$ | I | Prescaler input pin for the RF-PLL.<br>Connection to an external VCO should be via AC coupling. |
| 14 | 13 | LE | I | Load enable signal inpunt (with a schmitt trigger input buffer.)<br>When the LE bit is set “H”, data in the shift register is transferred to the corresponding latch according to the control bit in the serial data. |
| 15 | 14 | Data | I | Serial data input (with a schmitt trigger input buffer.)<br>A data is transferred to the corresponding latch (IF-ref counter, IF-prog. counter, RF-ref. counter, RF-prog. counter) according to the control bit in the serial data. |
| 16 | 15 | Clock | I | Clock input for the 23-bit shift register (with a schmitt trigger input buffer.)<br>One bit of data is shifted into the shift register on a rising edge of the clock. |

## ■ BLOCK DIAGRAM



## ■ ABSOLUTE MAXIMUM RATINGS

| Parameter | Symbol | Rating | | Unit | Remark |
|---|---|---|---|---|---|
| | | Min. | Max. | | |
| Power supply voltage | $V_{CC}$ | –0.5 | +4.0 | V | |
| Input voltage | $V_I$ | –0.5 | $V_{CC}$ +0.5 | V | |
| Output voltage | $V_O$ | GND | $V_{CC}$ | V | |
| Storage temperature | $T_{stg}$ | –55 | +125 | °C | |

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

## ■ RECOMMENDED OPERATING CONDITIONS

| Parameter | Symbol | Value | | | Unit | Remark |
|---|---|---|---|---|---|---|
| | | Min. | Typ. | Max. | | |
| Power supply voltage | $V_{CC}$ | 2.4 | 3.0 | 3.6 | V | |
| Input voltage | $V_I$ | GND | – | $V_{CC}$ | V | |
| Operating temperature | Ta | –40 | – | +85 | °C | |

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their FUJITSU representatives beforehand.

## ■ ELECTRICAL CHARACTERISTICS

($V_{CC}$ = 2.4 to 3.6 V, Ta = –40 to +85°C)

| Parameter | | Symbol | Condition | | Value | | | Unit |
|---|---|---|---|---|---|---|---|---|
| | | | | | Min. | Typ. | Max. | |
| Power supply current*1 | | $I_{CCIF}$*1 | $fin_{IF}$ = 223.15 MHz | $V_{CCIF}$ = 2.7 V | – | 1.2 | – | mA |
| | | | | ($V_{CCIF}$ = 3.0 V) | | (1.5) | | |
| | | $I_{CCRF}$*1 | $fin_{RF}$ = 1750 MHz | $V_{CCRF}$ = 2.7 V | – | 2.3 | – | mA |
| | | | | ($V_{CCRF}$ = 3.0 V) | | (2.5) | | |
| Power saving current | | $I_{PSIF}$ | $PS_{IF}$ = $PS_{RF}$ = "L" | | – | 0.1*2 | 10 | µA |
| | | $I_{PSRF}$ | $PS_{IF}$ = $PS_{RF}$ = "L" | | – | 0.1*2 | 10 | µA |
| Operating frequency | $fin_{IF}$*3 | $fin_{IF}$ | IF PLL | | 50 | – | 600 | MHz |
| | $fin_{RF}$*3 | $fin_{RF}$ | RF PLL | | 100 | – | 1750 | MHz |
| | $OSC_{IN}$ | fosc | – | | 3 | – | 40 | MHz |
| Input sensitivity | $fin_{IF}$*8 | $Pfin_{IF}$ | IF PLL, 50 Ω system | | –15 | – | +2 | dBm |
| | $fin_{RF}$ | $Pfin_{RF}$ | RF PLL, 50 Ω system | | –15 | – | +2 | dBm |
| | $OSC_{IN}$ | $V_{OSC}$ | – | | 0.5 | | $V_{CC}$ | Vp-p |
| "H" level input voltage | Data, Clock, LE, | $V_{IH}$ | Schmitt trigger input | | $V_{CC}$ × 0.7 + 0.4 | – | – | V |
| "L" level input voltage | | $V_{IL}$ | Schmitt trigger input | | – | – | $V_{CC}$ × 0.3 – 0.4 | |
| "H" level input voltage | PS | $V_{IH}$ | – | | $V_{CC}$ × 0.7 | – | – | V |
| "L" level input voltage | | $V_{IL}$ | – | | – | – | $V_{CC}$ × 0.3 | |
| "H" level input current | Data, Clock, LE, PS | $I_{IH}$*4 | – | | –1.0 | – | +1.0 | µA |
| "L" level input current | | $I_{IL}$*4 | – | | –1.0 | – | +1.0 | |
| "H" level input current | $OSC_{IN}$ | $I_{IH}$ | – | | 0 | – | +100 | µA |
| "L" level input current | | $I_{IL}$*4 | – | | –100 | – | 0 | |
| "H" level output voltage | LD/fout | $V_{OH}$ | $V_{CC}$ = 3 V, $I_{OH}$ = –1 mA | | $V_{CC}$ – 0.4 | – | – | V |
| "L" level output voltage | | $V_{OL}$ | $V_{CC}$ = 3 V, $I_{OL}$ = 1 mA | | – | – | 0.4 | |
| "H" level output voltage | $Do_{IF}$ $Do_{RF}$ | $V_{DOH}$ | $V_{CC}$ = 3 V, $I_{DOH}$ = –0.5 mA | | $V_{CC}$ – 0.4 | – | – | V |
| "L" level output voltage | | $V_{DOL}$ | $V_{CC}$ = 3 V, $I_{DOL}$ = 0.5 mA | | – | – | 0.4 | |
| High impedance cutoff current | $Do_{IF}$ $Do_{RF}$ | $I_{OFF}$ | $V_{CC}$ = 3 V, $V_{OFF}$ = 0.5 V to $V_{CC}$ –0.5V | | – | – | 2.5 | nA |
| "H" level output current | LD/fout | $I_{OH}$*4 | $V_{CC}$ = 3 V | | –1.0 | – | – | mA |
| "L" level output current | | $I_{DOL}$*4 | $V_{CC}$ = 3 V | | – | – | 1.0 | |
| "H" level output current | $Do_{IF}$ $Do_{RF}$ | $I_{DOH}$*4 | $V_{CC}$ = 3 V, $V_{DOH}$ = $V_{CC}$/2, Ta = +25°C | CS bit = "H" | – | –6.0 | – | mA |
| | | | | CS bit = "L" | – | –1.5 | – | |

*(Continued)*

*(Continued)*

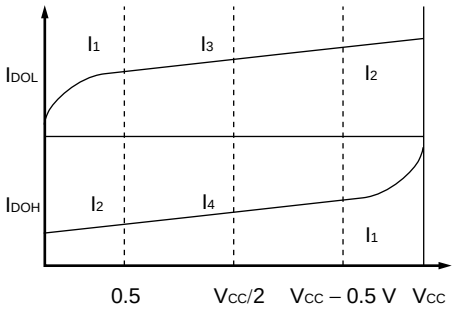
($V_{CC}$ = 2.4 to 3.6 V, Ta = –40 to +85°C)

| Parameter | | Symbol | Condition | | Value | | | Unit |
|---|---|---|---|---|---|---|---|---|
| | | | | | Min. | Typ. | Max. | |
| "L" level output current | $D_{OIF}$ $D_{ORF}$ | $I_{DOL}$ | $V_{CC}$ = 3 V, $V_{DOL}$= $V_{CC}$/2, Ta = +25°C | CS bit = "H" | – | 6.0 | – | mA |
| | | | | CS bit = "L" | – | 1.5 | – | |
| Charge pump current rate | $I_{DOL}/I_{DOH}$ | $I_{DOMT}$*5 | $V_{DO}$ = $V_{CC}$/2 | | – | 3 | – | % |
| | vs $V_{DO}$ | $I_{DOVD}$*6 | 0.5 V ≤ $V_{DO}$ ≤ $V_{CC}$ – 0.5 V | | – | 10 | – | % |
| | vs Ta | $I_{DOTA}$*7 | –40°C ≤ Ta ≤+ 85°C, $V_{DO}$ = $V_{CC}$/2 | | – | 10 | – | % |

*1: Conditions; fosc = 12 MHz, Ta = +25°C, in locking state.
*2: $V_{CCIF}$ = $V_{CCRF}$ = 3.0 V, fosc = 12.8 MHz, Ta = +25°C, in power saving state.
*3: AC coupling. 1000pF capacitor is connected under the condition of min. operating frequency.
*4: The symbol "–" (minus) means direction of current flow.
*5: $V_{CC}$ = 3.0 V, Ta = +25°C $(|I_3| - |I_4|)/[(|I_3| + |I_4|)]/2] \times 100(\%)$
*6: $V_{CC}$ = 3.0 V, Ta = +25°C $[(|I_2| - |I_1|)/2]/[(|I_1| + |I_2|)/2] \times 100(\%)$ (Applied to each $I_{DOL}$, $I_{DOH}$)
*7: $V_{CC}$ = 3.0 V, $[|I_{DO(85°C)} - I_{DO(-40°C)}|/2]/[I_{DO(85°C)} + I_{DO(-40°C)}|/2] \times 100(\%)$ (Applied to each $I_{DOL}$, $I_{DOH}$)
*8: Prescaler divide ratio C/P current fin operating frequency Input sensitivity

| | | | |
|---|---|---|---|
| 16/17 | 1.5 mA mode | 50 MHz ≦ fin ≦ 600 MHz | –15 dBm |
| | 6.0 mA mode | 50 MHz ≦ fin ≦ 300 MHz | –15 dBm |
| | | 300 MHz < fin ≦ 600 MHz | –10 dBm |
| 8/9 | 1.5 mA mode | 50 MHz ≦fin ≦ 300 MHz | –15 dBm |
| | | 300 MHz < fin ≦ 600 MHz* | –15 dBm |
| | 6.0 mA mode | 50 MHz ≦ fin ≦ 300 MHz | –15 dBm |
| | | 300 MHz < fin ≦ 600 MHz* | –10 dBm |

* : $V_{CC}$ = 3.0 V to 3.6 V at 600 MHz




Charge Pump Output voltage (V)

## ■ FUNCTIONAL DESCRIPTION

The divide ratio can be calculated using the following equation:

$f_{VCO} = [(M \times N) + A] \times f_{OSC} \div R \quad (A < N)$

- $f_{VCO}$ : Output frequency of external voltage controlled oscillator (VCO)
- M : Preset divide ratio of dual modulus prescaler (8or 16 for IF-PLL, 64 or 128 for RF-PLL)
- N : Preset divide ratio of binary 11-bit programmable counter (3 to 2,047)
- A : Preset divide ratio of binary 7-bit swallow counter ($0 \le A \le 127$)
- $f_{OSC}$ : Reference oscillation frequency
- R : Preset divide ratio of binary 14-bit programmable reference counter (3 to 16,383)

### Serial Data Input

Serial data is entered using three pins, Data pin, Clock pin, and LE pin. Programmable dividers of IF/RF-PLL sections, programmable reference dividers of IF/RF-PLL sections are controlled individually.
Serial data of binary data is entered through Data pin.
On rising edge of Clock, one bit of serial data is transferred into the shift register. When the LE signal is taken high, the data stored in the shift register is transferred to one of latch of them depending upon the control bit data setting.

### Table.1 Control Bit

| Control bit | | Destination of serial data |
|---|---|---|
| CN1 | CN2 | |
| L | L | The programmable reference counter for the IF-PLL |
| H | L | The programmable reference counter for the RF-PLL |
| L | H | The programmable counter and the swallow counter for the IF-PLL |
| H | H | The programmable counter and the swallow counter for the RF-PLL |

### Shift Register Configuration

**Programmable Reference Counter**

LSB ↓ Data Flow → MSB ↓

| 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 | 19 | 20 | 21 | 22 | 23 |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| CN1 | CN2 | T1 | T2 | R1 | R2 | R3 | R4 | R5 | R6 | R7 | R8 | R9 | R10 | R11 | R12 | R13 | R14 | CS | X | X | X | X |

CN1,2 : Control bit [Table. 1]
R1 to R14 : Divide ratio setting bit for the programmable reference counter (5 to 16,383) [Table. 2]
T1, 2 : Test purpose bit [Table. 3]
CS : Charge pump currnet select bit [Table. 9]
X : Dummy bits (Set “0” or “1”)

**NOTE**: Data input with MSB first.

**Programmable Counter**

LSB ↓ Data Flow → MSB ↓

| 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 | 19 | 20 | 21 | 22 | 23 |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| CN1 | CN2 | LDS | $SW_{IF/RF}$ | $FC_{IF/RF}$ | A1 | A2 | A3 | A4 | A5 | A6 | A7 | N1 | N2 | N3 | N4 | N5 | N6 | N7 | N8 | N9 | N10 | N11 |

CNT1, 2 : Control bit [Table. 1]
N1 to N11: Divide ratio setting bits for the programmable counter (3 to 2,047) [Table. 4]
A1 to A7 : Divide ratio setting bits for the swallow counter (0 to 127) [Table. 5]
$SW_{IF/RF}$ : Divide ratio setting bits for the prescaler [Table. 6]
(8/9 or 16/17 for the $SW_{IF}$, 64/65 or 128/129 for the $SW_{RF}$)
$FC_{IF/RF}$ : Phase control bit for the phase detector (IF: $FC_{IF}$, RF: $FC_{RF}$) [Table. 7]
LDS : LD/fout signal select bit [Table. 8]
**NOTE:** Data input with MSB first.

**Table2. Binary 14-bit Programmable Reference Counter Data Setting**

| Divide ratio (R) | R 14 | R 13 | R 12 | R 11 | R 10 | R 9 | R 8 | R 7 | R 6 | R 5 | R 4 | R 3 | R 2 | R 1 |
|---|---|---|---|---|---|---|---|---|---|---|---|---|---|---|
| 3 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 |
| 4 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 |
| . | . | . | . | . | . | . | . | . | . | . | . | . | . | . |
| 16383 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |

Note: Divide ratio less than 3 is prohibited.

**Table.3 Test Purpose Bit Setting**

| T 1 | T 2 | LD/fout pin state |
|---|---|---|
| L | L | Outputs $fr_{IF}$ |
| H | L | Outputs $fr_{RF}$ |
| L | H | Outputs $fp_{IF}$ |
| H | H | Outputs $fp_{RF}$ |

**Table.4 Brinary 11-bit Programmable Counter Data Setting**

| Divide ratio (N) | N 11 | N 10 | N 9 | N 8 | N 7 | N 6 | N 5 | N 4 | N 3 | N 2 | N 1 |
|---|---|---|---|---|---|---|---|---|---|---|---|
| 3 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 |
| 4 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 |
| . | . | . | . | . | . | . | . | . | . | . | . |
| 2047 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |

Note: Divide ratio less than 3 is prohibited.

**Table.5 Brinary 7-bit Swallow Counter Data Setting**

| Divide ratio (N) | A 7 | A 6 | A 5 | A 4 | A 3 | A 2 | A 1 |
|---|---|---|---|---|---|---|---|
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 1 | 0 | 0 | 0 | 0 | 0 | 0 | 1 |
| . | . | . | . | . | . | . | . |
| 127 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |

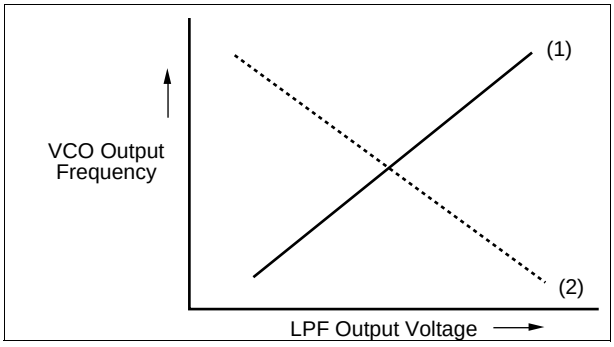
Note: Divide ratio (A) range = 0 to 127

**Table.6 Prescaler Data Setting**

| | | SW = "H" | SW = "L" |
|---|---|---|---|
| **Prescaler divide ratio** | **IF-PLL** | 8/9 | 16/17 |
| | **RF-PLL** | 64/65 | 128/129 |

**Table.7 Phase Comparator Phase Switching Data Setting**

| | $FC_{IF, RE}$ = H | $FC_{IF, RE}$ = L |
|---|---|---|
| | $DO_{IF, RF}$ | |
| fr > fp | H | L |
| fr = fp | Z | Z |
| fr < fp | L | H |
| VCO polarity | (1) | (2) |




Note: Z = High-impedance
Depending upon the VCO and LPF polarity, FC bit should be set.

**Table.8 LD/fout Output Select Data Setting**

| LDS | LD/fout output signal |
|---|---|
| H | fout ($fr_{IF/RF}$, $fp_{IF/RF}$) signals |
| L | LD signal |

**Table.9 Charge Pump Current Setting**

| CS | Current value |
|---|---|
| H | ±6.0 mA |
| L | ±1.5 mA |

## Power Saving Mode (Intermittent Mode Control Circuit)

**Table.10 PS Pin Setting**

| PS pin | Status |
|---|---|
| H | Normal mode |
| L | Power saving mode |

The intermittent mode control circuit reduces the PLL power consumption.

By setting the PS pin low, the device enters into the power saving mode, reducing the current consumption. See the Electrical Characteristics chart for the specific value.

The phase detector output, Do, becomes high impedance.

For the dual PLL, the lock detector, LD, is as shown in the LD Output Logic table.

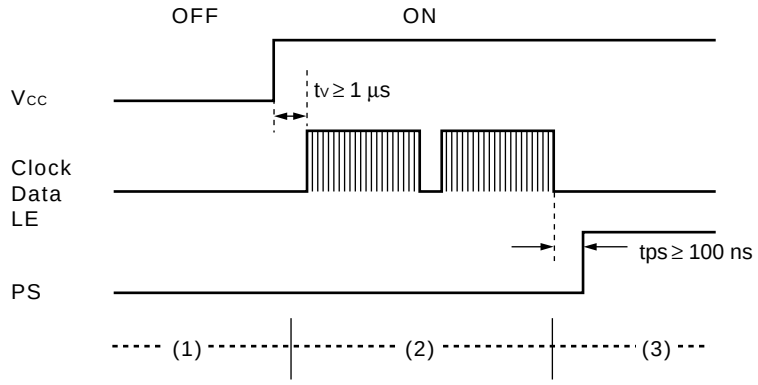
Setting the PS pin high, releases the power saving mode, and the device works normally.

The intermittent mode control circuit also ensures a smooth startup when the device returns to normal operation. When the PLL is returned to normal operation, the phase comparator output signal is unpredictable. This is because of the unknown relationship between the comparison frequency (fp) and the reference frequency (fr) which can cause a major change in the comparator output, resulting in a VCO frequency jump and an increase in lockup time.

To prevent a major VCO frequency jump, the intermittent mode control circuit limits the magnitude of the error signal from the phase detector when it returns to normal operation.

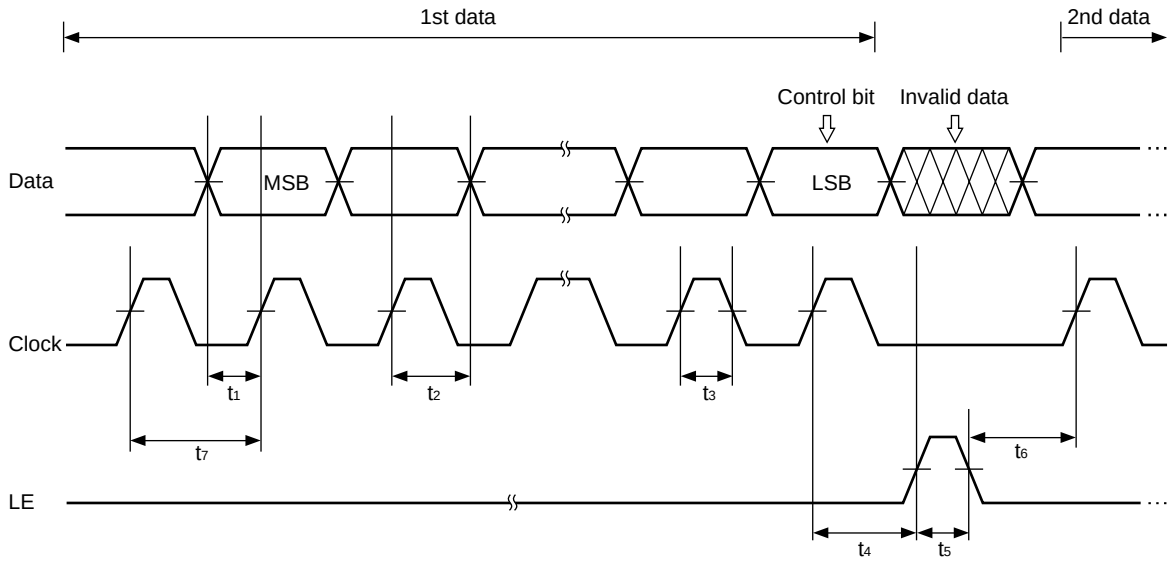
Note: When power ($V_{CC}$) is first applied, the device must be in standby mode, PS = Low, for at least 1 µs.

Note: PS pin must be set “L” for Power-ON.




(1) PS = L (power saving mode) at Power-ON
(2) Set serial data 1 µs later after power supply remains stable (VCC ≥ 2.2 V).
(3) Release power saving mode (PS : L → H) 100 ns later after setting serial data.

## ■ SERIAL DATA INPUT TIMING



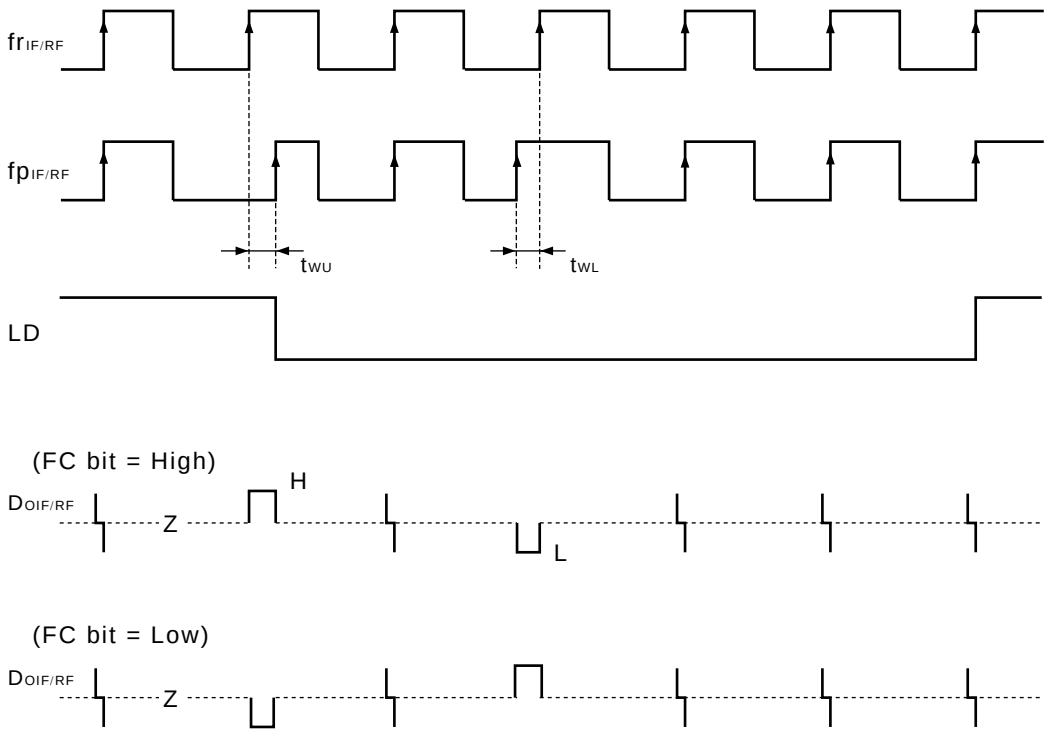

On rising edge of the clock, one bit of the data is transferred into the shift register.

| Parameter | Min. | Typ. | Max. | Unit |
|---|---|---|---|---|
| t1 | 20 | – | – | ns |
| t2 | 20 | – | – | ns |
| t3 | 30 | – | – | ns |
| t4 | 30 | – | – | ns |

| Parameter | Min. | Typ. | Max. | Unit |
|---|---|---|---|---|
| t5 | 100 | – | – | ns |
| t6 | 20 | – | – | ns |
| t7 | 100 | – | – | ns |

Note: LE should be “L” when the data is transferred into the shift register.

## ■ PHASE COMPARATOR OUTPUT WAVEFORM

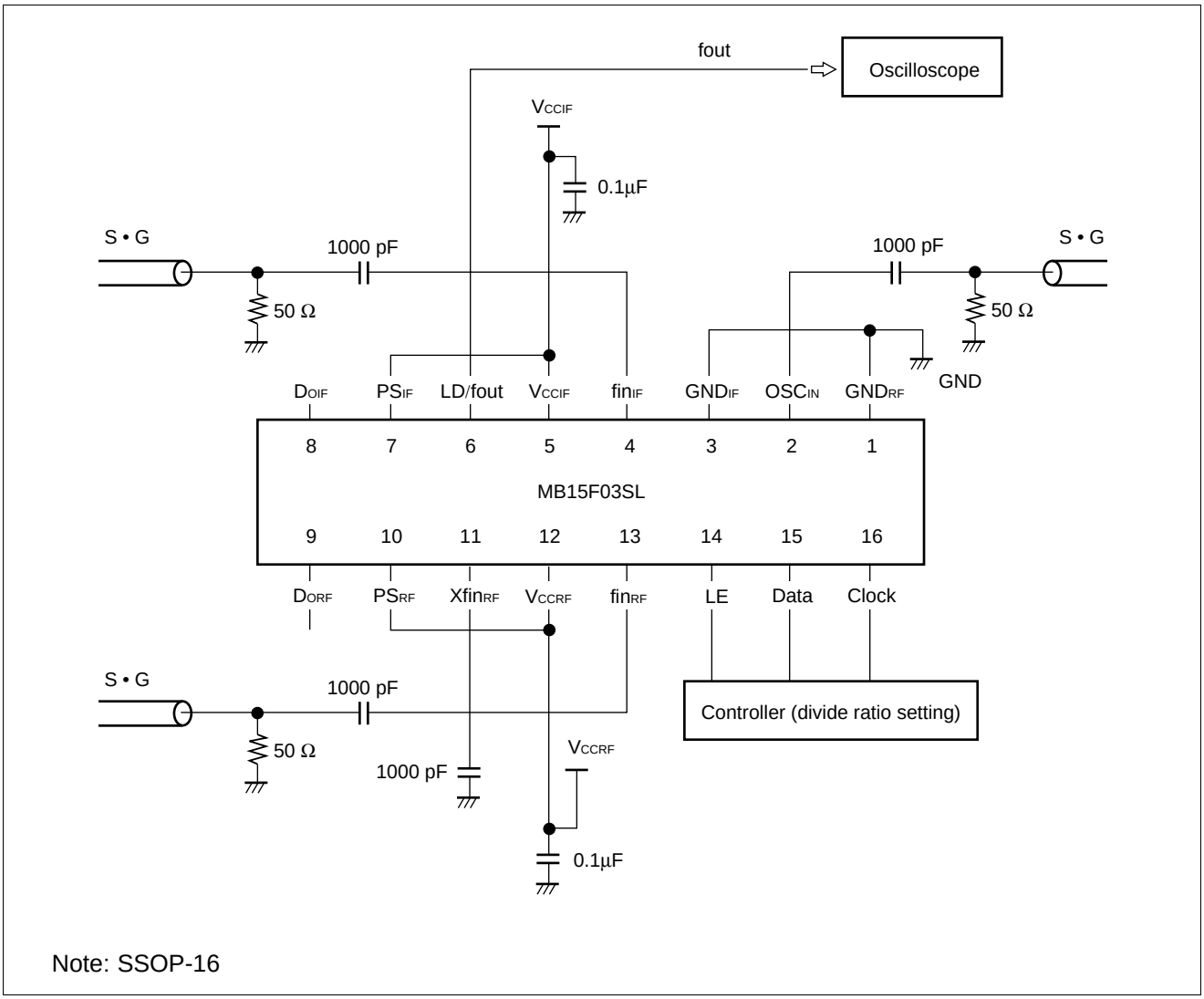



**LD Output Logic Table**

| IF-PLL section | RF-PLL section | LD output |
|---|---|---|
| Locking state/Power saving state | Locking state/Power saving state | H |
| Locking state/Power saving state | Unlocking state | L |
| Unlocking state | Locking state/Power saving state | L |
| Unlocking state | Unlocking state | L |

Notes:
- Phase error detection range = $-2\pi$ to $+2\pi$
- Pulses on $Do_{IF/RF}$ signals are output to prevent dead zone.
- LD output becomes low when phase error is $t_{WU}$ or more.
- LD output becomes high when phase error is $t_{WL}$ or less and continues to be so for three cycles or more.
- $t_{WU}$ and $t_{WL}$ depend on OSCin input frequency as follows.
  $t_{WU} \geq 2/fosc$: i. e. $t_{WU} \geq 156.3$ ns when foscin = 12.8 MHz
  $t_{WU} \leq 4/fosc$: i. e. $t_{WL} \leq 312.5$ ns when foscin = 12.8 MHz

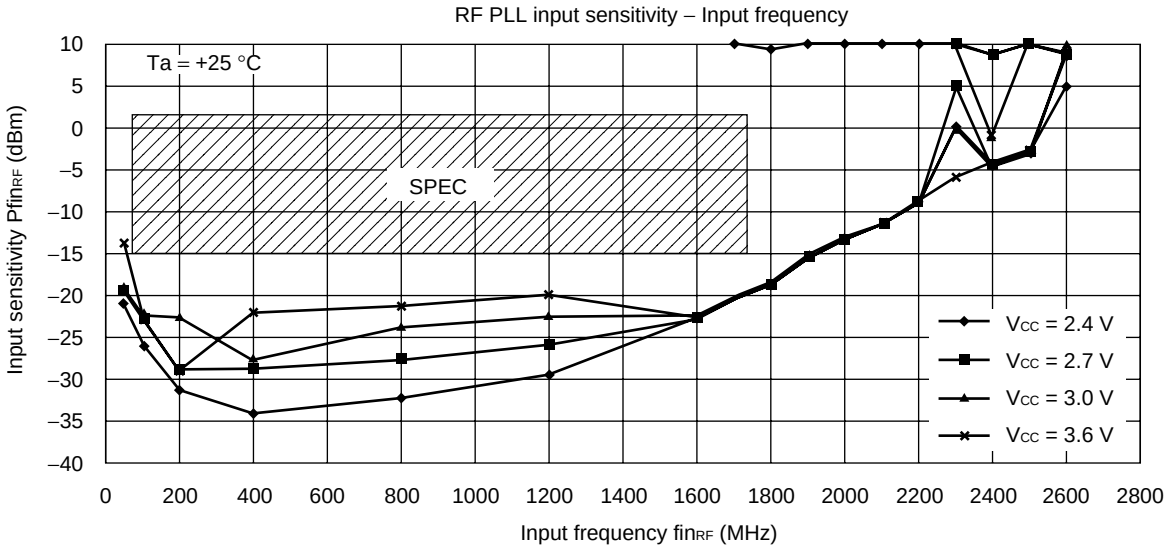
## ■ MEASURMENT CIRCUIT (for Measuring Input Sensitivity fin/OSCin)

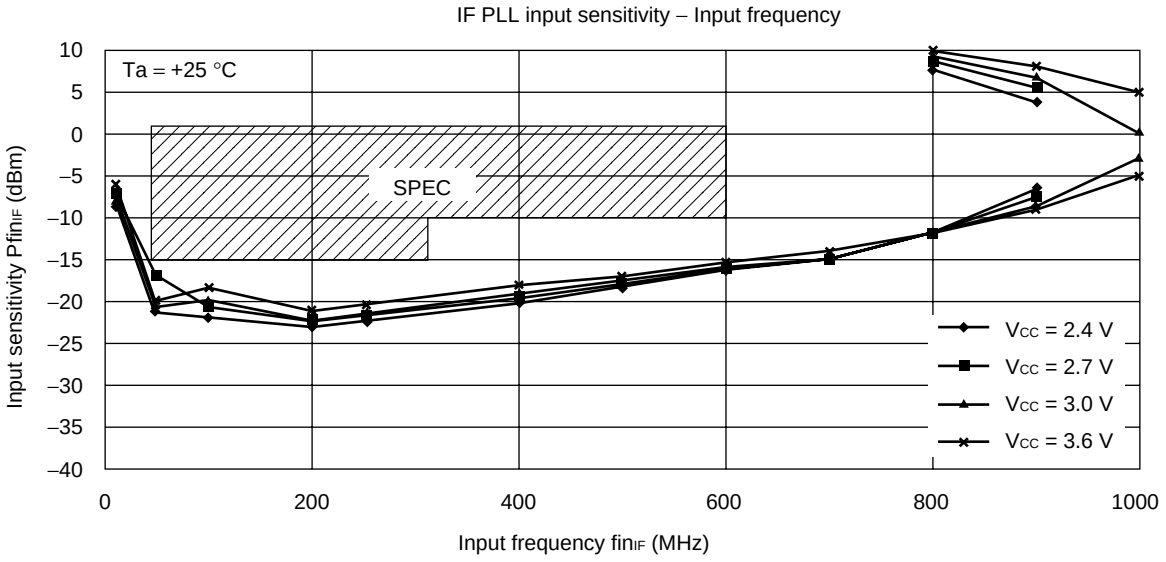



Note: SSOP-16

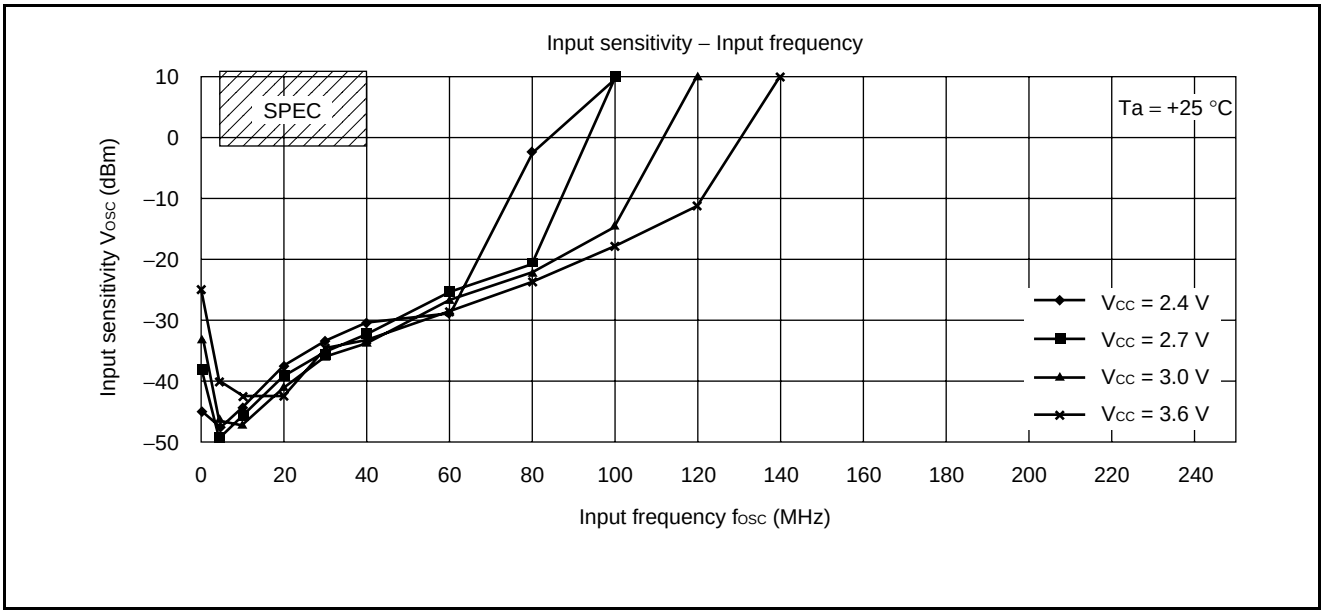
## ■ TYPICAL CHARACTERISTICS

1. fin input sensitivity



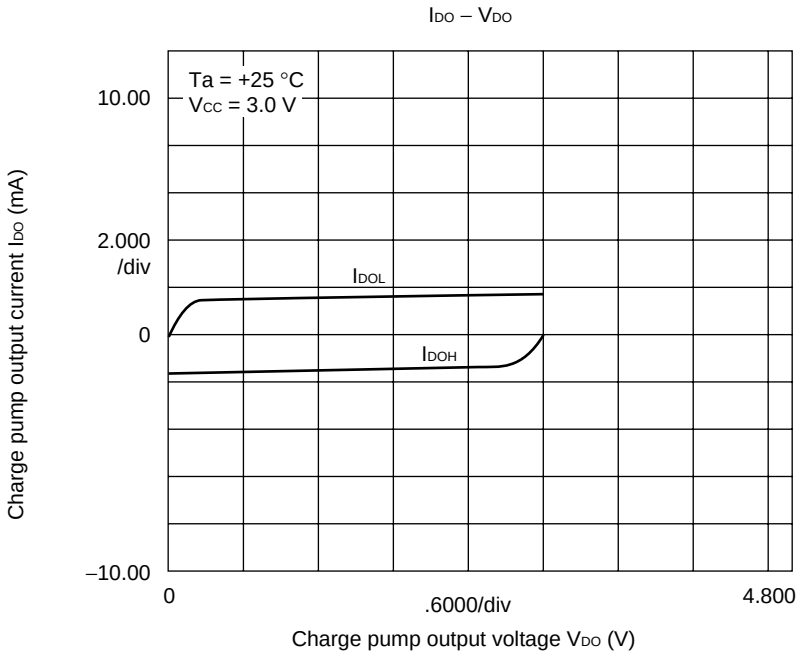



2. $OSC_{IN}$ input sensitivity

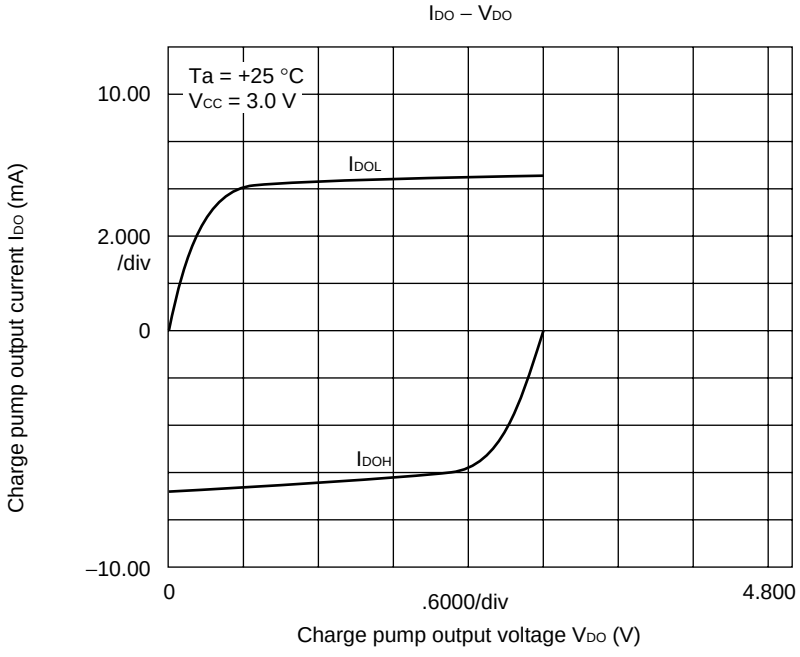


3. Do output current (RF PLL)

1.5 mA mode

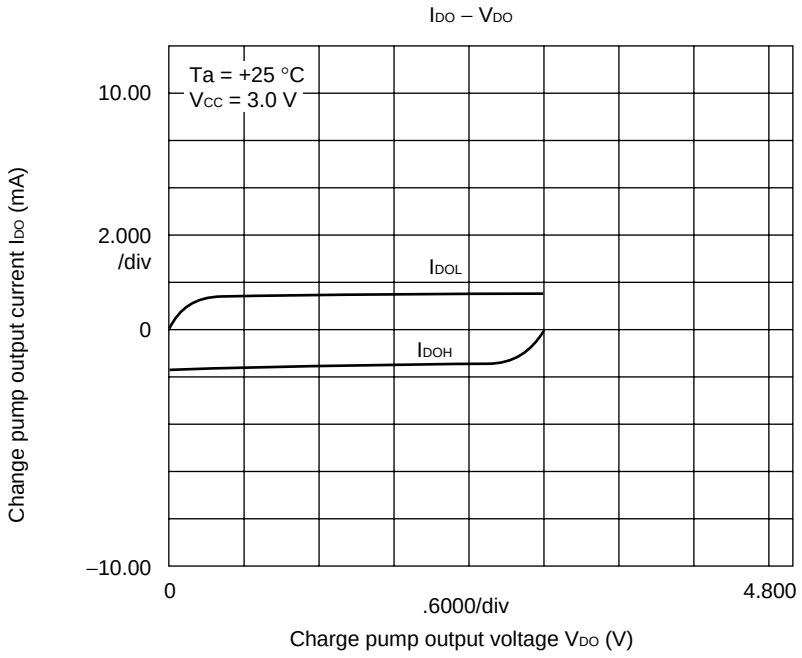



6.0 mA mode

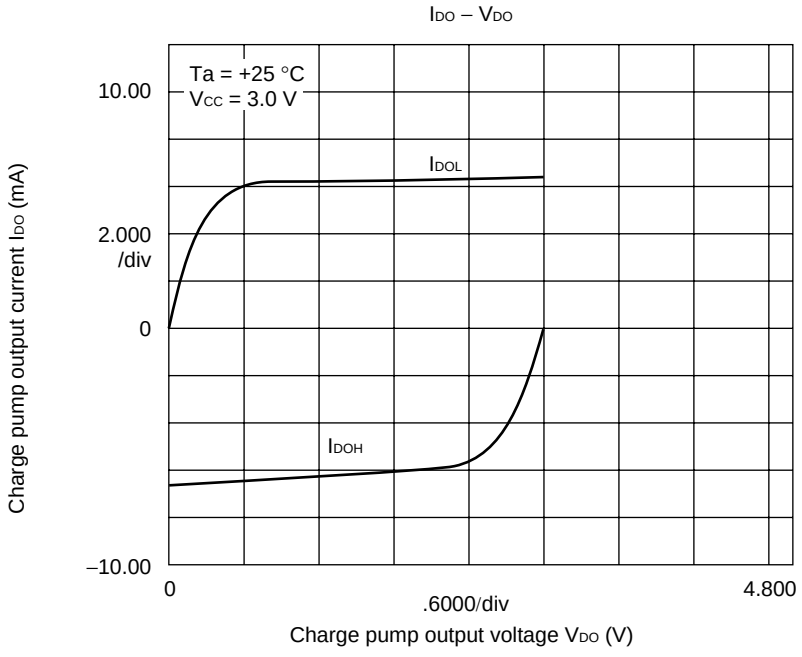


4. Do output current (IF PLL)

1.5 mA mode

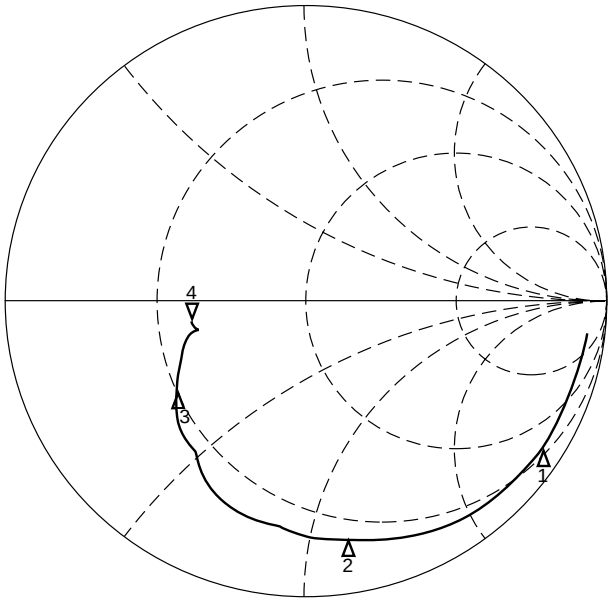



6.0 mA mode

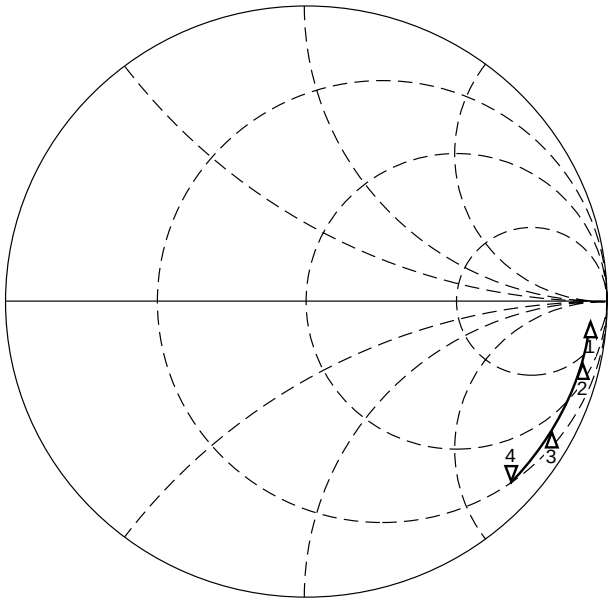


5. fin input impedance

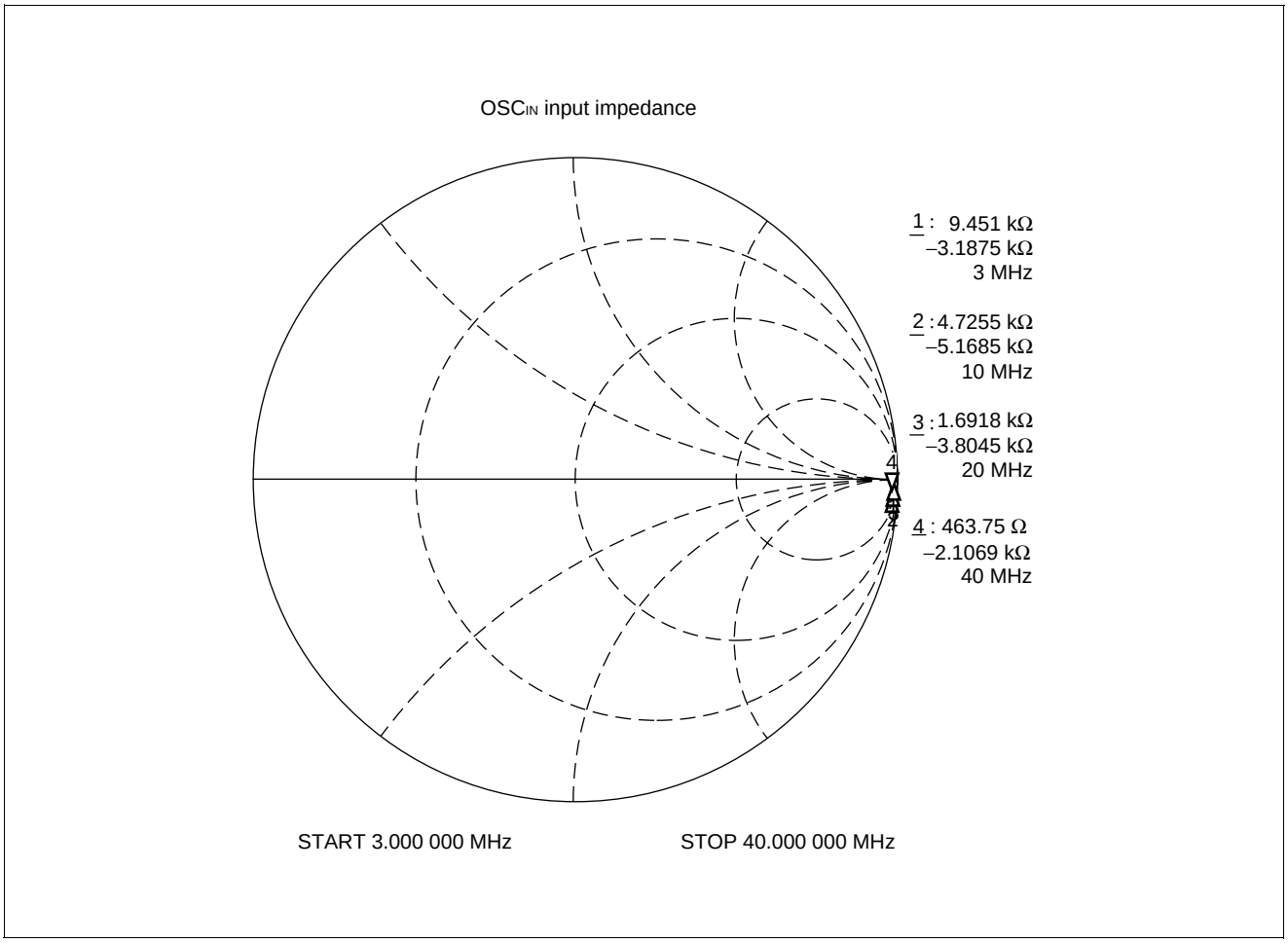
finRF input impedance



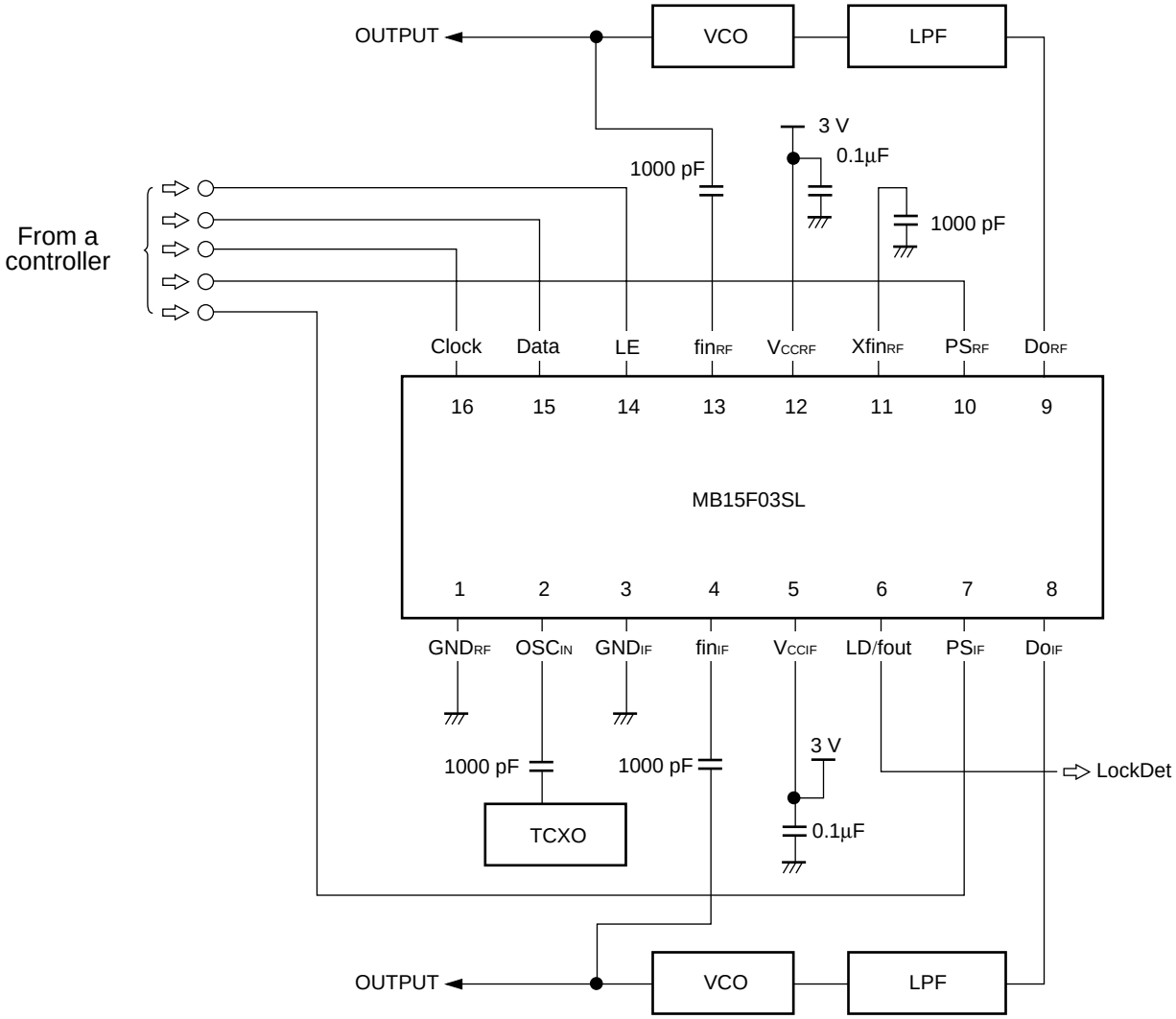

finIF input impedance



6. $OSC_{IN}$ input impedance



## ■ APPLICATION EXAMPLE




Note: SSOP-16

## ■ USAGE PRECAUTIONS

(1) $V_{CCRF}$ must equa $V_{CCIF}$.
Even if either RF-PLL or IF-PLL is not used, power must be supplied to both $V_{CCRF}$ and $V_{CCIF}$ to keep them equal. It is recommended that the non-use PLL is controlled by power saving function.

(2) To protect damage by electrostatic discharge, note the following handling precautions:
-Store and transport devices in conductive containers.
-Use properly grounded workstations, tools, and equipment.
-Tum off power before inserting or removing this device into or from a socket.
-Protect leads with conductive sheet, when transporting a board mounted device.

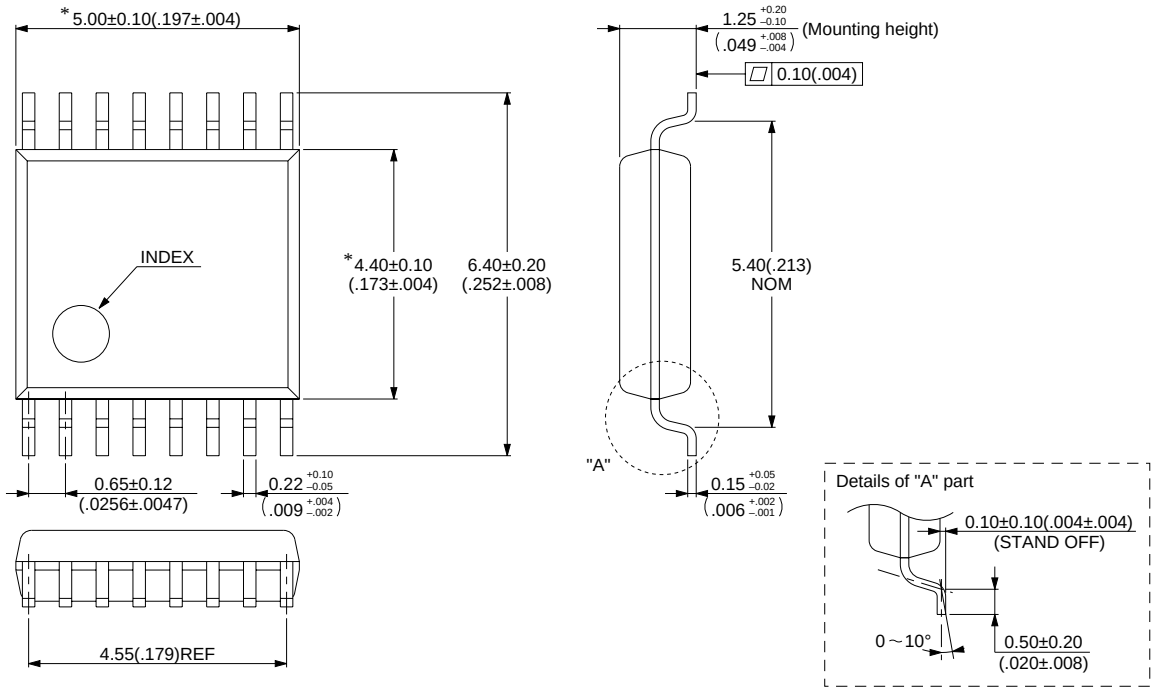
## ■ ORDERING INFORMATION

| Part number | Package | Remarks |
|---|---|---|
| MB15F03SLPFV1 | 16-pin, plastic SSOP<br>(FPT-16P-M05) | |
| MB15F03SLPV1 | 16-pad, plastic BCC<br>(LCC-16P-M04) | |

## ■ PACKAGE DIMENSIONS

16-pin plastic SSOP
(FPT-16P-M05)

* : These dimensions do not include resin protrusion.



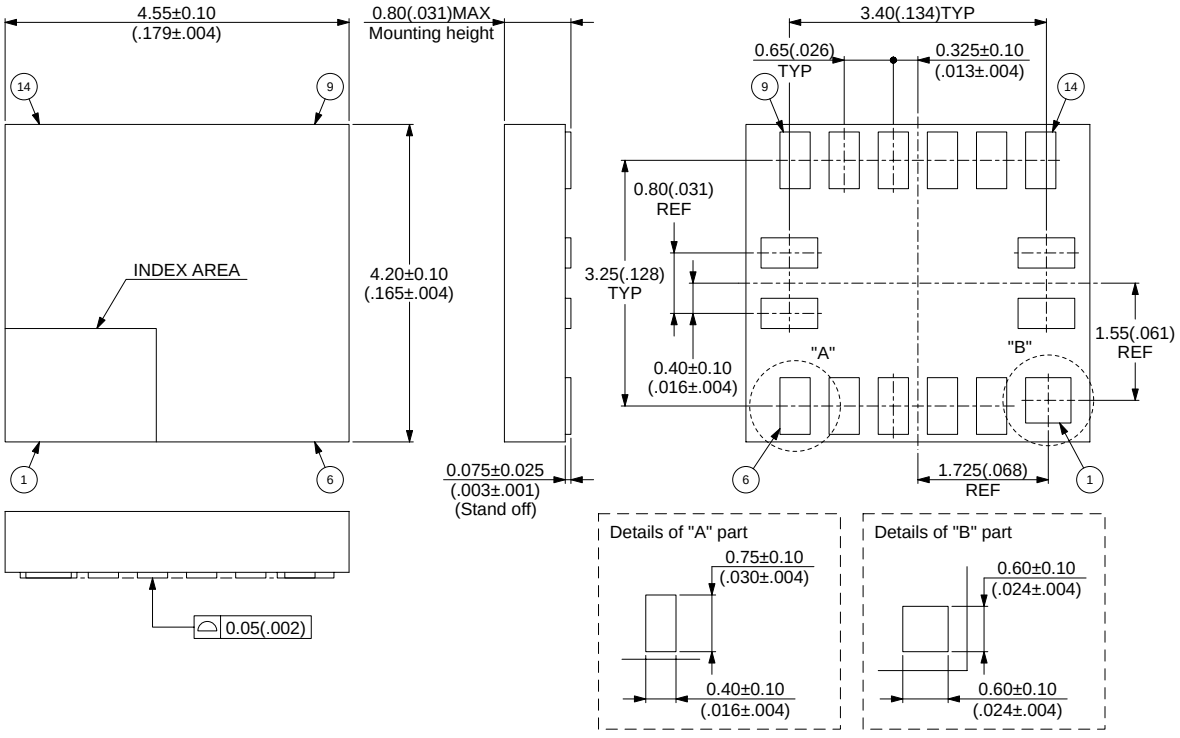



Dimensions in mm (inches)

*(Continued)*

*(Continued)*

16-pad plastic BCC
(LCC-16P-M04)






Dimensions in mm (inches)

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